## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | MOON ET AL. | Examiner | Art Unit | Gelek Topgyal | 2621 | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0176693	11-2002	Cho et al.	386/95
*	В	US-2004/0046778	03-2004	Niranjan et al.	345/716
*	С	US-5,455,684	10-1995	Fujinami et al.	386/111
*	D	US-2006/0242117	10-2006	Chung et al.	707/003
*	E	US-7,139,470	11-2006	Lopez-Estrada et al.	386/109
*	F	US-2003/0012558	01-2003	Kim et al.	386/97
*	G	US-2003/0039470	02-2003	Otsuka et al.	386/95
*	Н	US-2002/0078144	06-2002	Lamkin et al.	709/203
	_	US-			
	7	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

	NON I ALEM BOOGHEMO							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
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	<b>&gt;</b>							
	8							
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.